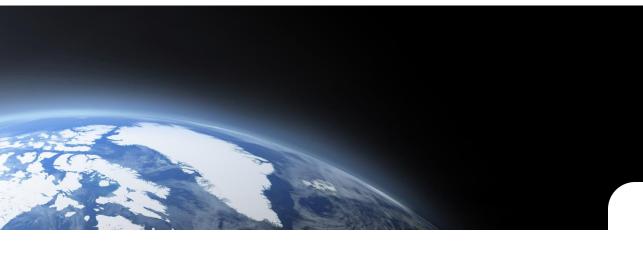
Power Matters





Radiation Hardened Discrete Products & Hybrids Roadmap

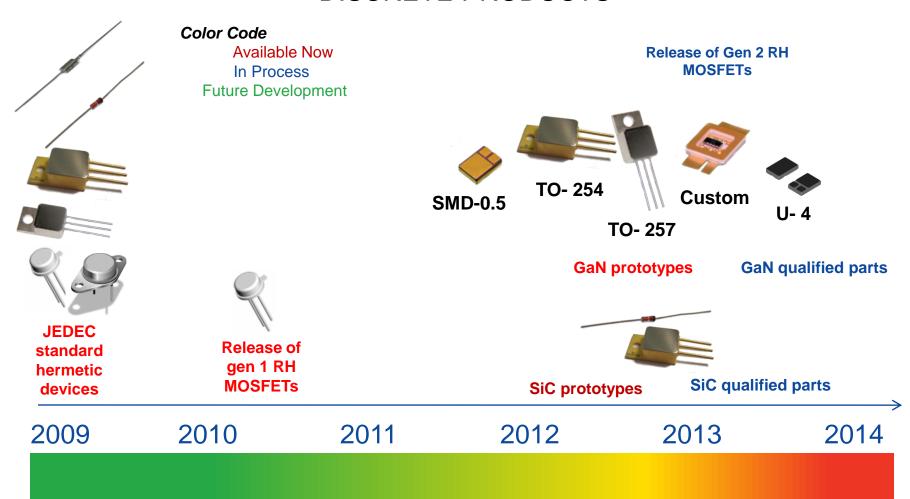
Microsemi Space Forum Russia – November 2013

Al Ortega Product Line Manager, HiRel Group



Product Strategy & Roadmap

DISCRETE PRODUCTS





Product Strategy & Roadmap

HYBRID PRODUCTS

Color Code

Available Now In Process Future Development



Solid State Relays









SOI Process
Integrated high
efficiency POI
Controllers



Custom Hybrid products



Silicon based Linear regulators



Si based Quad hybrid POL



Hip50 Hardened Isolated Power Series High Efficiency RH Isolated DC-DC Hybrid using GaN

SiC qualified parts Bridge Rectifiers

1990-2009

2010

2011

Si based single POL's 3A or 5A

2012

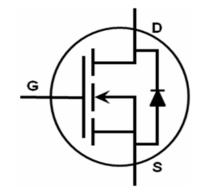
2013

2014

2015













Radiation Hardened MOSFETs

Gen1 MSC Rad Hard MOSFETs 60V to 200V IR Gen IV Direct Cross





RH1 Radiation Hardened MOSFETs

- RH1 radiation-hardened MOSFET complete
 - Voltage range from 60 V 200 V
 - 24 new part numbers / 9 base device types
 - N and P channel
 - Five package types
 - Through hole and surface mount
 - TID to 300Krad & SEE hardening



- Cross-References available
- New Gen 1 "Die" availabilities







Microsemi / QPL Part Number	СН	BVDSS MIN	VGS MAX	RDS(on) MAX	ID MAX	PD MAX	Max TID Rating	Slash Sheet
r art Number		V	V	mΩ	А	W	(K RAD)	511661
JANSR2N7268	Ν	100	±20	65	34	150	100	/603
JANSF2N7268	Ν	100	±20	65	34	150	300	/603
JANSR2N7269	Ν	200	±20	100	26	150	100	/603
JANSF2N7269	N	200	±20	100	26	150	300	/603

RH1 RAD HARD MOSFET Portfolio

TO-39 Hermetic Package (TO-205AF)



TO-39 = 8.5 mm CAN; 12.2 mm min LL

Microsemi / QPL Part Number	СН	BVDSS MIN	VGS MAX	RDS(on) MAX	ID MAX	PD MAX	Max TID Rating	Slash Sheet
Part Number		V	V	mΩ	Α	W	(K RAD)	Silect
JANSR2N7389	Р	-100	±20	300	6.5	25	100	/630
JANSF2N7389	Р	-100	±20	300	6.5	25	300	/630
JANSR2N7261	N	100	±20	180	8.0	25	100	/601
JANSF2N7261	N	100	±20	180	8.0	25	300	/601
JANSR2N7262	N	200	±20 ,	350	5.5	25	100	/601
JANSF2N7262	N	200	±20	350	5.5	25	300	/601

TO-257AA Hermetic Package



TO-257 = L 16.7 X W 10.7 X H 5.2mm

Microsemi / QPL Part Number	СН	BVDSS MIN	VGS MAX	RDS(on) MAX	ID MAX	PD MAX	Max TID Rating	Slash Sheet
rait Nullibei		V	V	mΩ	Α	W	(K RAD)	511661
JANSM2N7382	Р	-100	±20	300	11.0	75	3	/615
JANSD2N7382	Р	-100	±20	300	11.0	75	10	/615
JANSR2N7382	Р	-100	±20	300	11.0	75	100	/615
JANSF2N7382	Р	-100	±20	300	11.0	75	300	/615
JANSR2N7380	N	100	±20	180	14.4	75	100	/614
JANSF2N7380	Ν	100	±20	180	14.4	75	300	/614
JANSR2N7381	Ν	200	±20	400	9.4	75	100	/614
JANSF2N7381	N	200	±20	400	9.4	75	300	/614

RH1 Radiation Hardened MOSFET Portfolio

SMD1 Hermetic Package (TO-267AB Surface Mount)



SMD1 = L 16 X W 11.5 X H 3.6 mm

Microsemi / QPL Part Number	СН	BVDSS MIN	VGS MAX	RDS(on) MAX	ID MAX	PD MAX	Max TID Rating	Slash Sheet
r art Number		V	V	mΩ	Α	W	(K RAD)	Silect
JANSR2N7268U	Z	100	±20	65	34.0	150	100	/603
JANSF2N7268U	Z	100	±20	65	34.0	150	300	/603
JANSR2N7269U	Z	200	±20	100	26.0	150	100	/603
JANSF2N7269U	Ν	200	±20	100	26.0	150	300	/603

18-PIN LCC Hermetic Package (Surface Mount)



8 PIN LCC = L 9.1 X W 7.5 X H 2.9 mm

Microsemi / QPL Part Number		BVDSS MIN	VGS MAX	RDS(on) MAX	ID MAX	PD MAX	Max TID Rating (K RAD)	Slash Sheet
		V	V	mΩ	А	W	(K KAD)	
JANSR2N7389U	Р	-100	±20	300	6.5	25	100	/630
JANSF2N7389U	Р	-100	±20	300	6.5	25	300	/630
JANSR2N7261U	Ν	100	±20	180	8.0	25	100	/601
JANSF2N7261U	Ν	100	±20	180	8.0	25	300	/601
JANSR2N7262U	Ν	200	±20	350	5.5	25	100	/601
JANSF2N7262U	Ν	200	±20	350	5.5	25	300	/601



JANHC and JANKC Die Qualification Extension

- RH1 Die availabilities
 - JANHC and JANKC die qualification extensions have been allocated by DLA to our Gen-1 die product offerings
 - Reference number VQE-13-025437 and control number 037833 have been assigned by DLA to this approval which was effective 19 November 2012
 - Portfolio of devices includes all packaged variants of N-channel, Pchannel 100 volt and 200 volt die to JANSF level

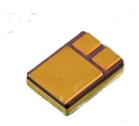
Part numbers	36D number	JANSF approval letter number	JANSF test report number
JANHCBF/ JANKCBF2N7382, 2N7389	36D-129	VQE-09-018474	19500-2632-09
JANHCBF/ JANKCBF2N7261, 2N7380	36D-130	VQE-10-020198	19500-2876-10
JANHCBF/ JANKCBF2N7262, 2N7381	36D-131	VQE-10-020199	19500-2877-10
JANHCBF/ JANKCBF2N7268	36D-132	VQE-10-020198	19500-2876-10
JANHCBF/ JANKCBF2N7269	36D-133	VQE-10-020199	19500-2877-10



Product Roadmap: Next-generation Radiation Hardened MOSFETs

- Microsemi RH2 radiation-hardened MOSFETs are now in end stages of prototype evaluations (100V)(Q3-2013)
- 200V (IMOS Process) expect rev2 prototypes (Q3-2013)
- Development plans
 - Voltage range from 30 V 250 V
 - Size 3 and size 6 die
 - Ultra low Rds(on)
 - Lower Qg
 - Improved single-event hardening
 - Equivalent to R6 from IR
 - IR cross-reference available
 - 60 new part numbers









RH2 MOSFET Development

- RH2= IR R6, N- Channel size 3 Die
- Two Processes: HMOS (Garden Grove)
 IMOS (Bend)
- 30V HMOS Process
 - Fab Development at GG
 - TO- 257, SMD0.5, TO- 39
 - JANSR2N7479U3, Qual: Q2, 2014
- 60V, HMOS
 - Engineering Design Units: November '13
 - TO- 257, SMD0.5, TO- 39
 - JANSR2N7587U3 /746, Qual: Q1 2014





TO-257





RH2 MOSFET Development

- RH2= IR R6, N- Channel size 3 Die
- Two Processes: HMOS (Garden Grove) IMOS (Bend)
- 150V size 3 die. (IMOS)
 - Engineering Design Units: November '13
 - JANSR2N7589U3 /746, Qual: Q1 2014
 - (HMOS, IMOS)



- 200V size 3 die. (IMOS)
 - Engineering Design Units: November '13
 - JANSR2N7591U3 /746, Qual: Mid 2014
 - New IMOS Process



Phase 1 RH2 portfolio- N- Channel, Sz 3



Bvdss V	RDS(on) Ω	<u>Channel</u>	JEDEC Number	Industry Equivalent	RH2 Base MSC p/n	<u>Package</u>	Slash Sheet
30	0.02	N	2N7479U3	IRHNJ57Z30	MRH03N22U3	SMD-0.5	703
30	0.03	N	2N7482T3	IRHY57Z30CM	MRH03N18T3	TO-257AA	702
60	0.08	N	2N7495U5	IRHE57034	MRH06N12U5	LCC-18	700
60	0.048	N	2N7492T2	IRHF57034	MRH06N12T2	TO-39	701
60	0.03	N	2N7480U3	IRHNJ57034	MRH06N22U3	SMD-0.5	703
60	0.04	N	2N7483T3	IRHY57034CM	MRH06N18T3	TO-257AA	702
100	0.11	N	2N7496U5	IRHE57130	MRH10N10U5	LCC-18	700
100	0.08	N	2N7493T2	IRHF57130	MRH10N??T2	TO-39	701
100	0.042	N	2N7587U3	IRHNJ67130	MRH10N22U3	SMD-0.5	746
130	0.13	N	2N7500U5	IRHE57133SE	MRH13N09U5	LCC-18	707
130	0.1	N	2N7497T2	IRHF57133SE	MRH13N09T2	TO-39	706
130	0.08	N	2N7485U3	IRHNJ57133SE	MRH13N19U3	SMD-0.5	704
150	0.088	N	2N7589U3	IRHNJ67134	MRH15N19U3	SMD-0.5	746
200	0.13	N	2N7591U3	IRHNJ67230	MRH20N22U3	SMD-0.5	746
200	0.13	N		IRHF67230	MRH20N12T2	TO- 39	
200	0.13	N		IRHYB67230CM	MRH20N12T3	TO-257	
250	0.42	N	2N7499T2	IRHF57234SE	MRH25N09T2	TO-39	706
250	0.21	N	2N7593U3	IRHNJ67234	MRH25N22U3	SMD-0.5	746
250	0.22	N	2N7494T3	IRHYS67234CM	MRH25N12T3	TO-257AA	755









IMOS

Phase 2 RH2 portfolio, N- Ch, Sz 6

Bvdss V	RDS(on) Ω	Channel	JEDEC Number	Industry Equivalent	RH2 Base MSC p/n	<u>Package</u>	Slash Sheet
30	0.0045	N	2N7478T1	IRHMS57Z60	MRH03N45T1	TO-254AA	697
30	0.0035	N	2N7467U2	IRHNA57Z60	MRH03N45U2	SMD-2	683
60	0.0066	N	2N7470T1	IRHMS57064	MRH06N45T1	TO-254AA	698
60	0.0056	N	2N7468U2	IRHNA57064	MRH06N56U1	SMD-2	673
100	0.011	N	2N7580T1	IRHMS67160	MRH10N45T1	TO-254	753
100	0.01	N	2N7579U2	IRHNA67160	MRH10N56U2	SMD-2	760
130	0.0135	N	2N7472U2	IRHNA57163SE	MRH13N56U1	SMD-2	684
150	0.019	N	2N7582T1	IRHMS67164	MRH15N45T1	TO-254	753
150	0.018	N	2N7581U2	IRHNA67164	MRH15N56U1	SMD-2	760
200	0.029	N	2N7584T1	IRHMS67260	MRH20N45T1	TO-254	753
200	0.028	N	2N7583U2	IRHNA67260	MRH20N56U1	SMD-2	760
250	0.041	N	2N7586T1	IRHMS67264	MRH25N45T1	TO-254	753
250	0.04	N	2N7585U2	IRHNA67264	MRH25N56U1	SMD-2	760









RH2 Radiation Hardened MOSFET Portfolio

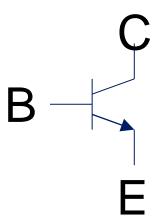
SMD-0.5 Hermetic Package (TO-276AB Surface Mount)

Misus sawi / ODI		BVDSS	V20 MAY	RDS(on)	ID MAY		Max TID	Clock
Microsemi / QPL Part Number	СН	MIN	VGS MAX	MAX	ID MAX	PD MAX	Rating	Slash Sheet
Part Number		V	V	m?	А	W	(K RAD)	Sneet
JANSR2N7479U3	N	30	±2 0	20	22.0	75	100	/703
JANSF2N7479U3	N	30	±2 0	20	22.0	75	300	/703
JANSR2N7480U3	N	60	±2 0	30	22.0	75	100	/703
JANSF2N7480U3	N	60	±2 0	30	22.0	75	300	/703
JANSR2N7587U3	N	100	±2 0	42	22.0	75	100	/746
JANSF2N7587U3	N	100	±2 0	42	22.0	75	300	/746
JANSR2N7589U3	N	150	±2 0	88	19.0	75	100	/746
JANSF2N7589U3	N	150	±2 0	88	19.0	75	300	/746
JANSR2N7591U3	N	200	±2 0	130	16.0	75	100	/746
JANSF2N7591U3	N	200	±2 0	130	16.0	75	300	/746
JANSR2N7593U3	N	250	±2 0	210	12.4	75	100	/746
JANSF2N7593U3	Ν	250	±2 0	210	12.4	75	300	/746
JANSR2N7519U3	Р	-30	±2 0	70	22.0	75	100	/732
JANSF2N7519U3	Р	-30	±2 0	70	22.0	75	300	/732
JANSR2N7520U3	Р	-60	±2 0	85	21.0	75	100	/732
JANSF2N7520U3	Р	-60	±2 0	85	21.0	75	300	/732
JANSR2N7545U3	Р	-100	±2 0	205	12.5	75	100	/712
JANSF2N7545U3	Р	-100	±2 0	205	12.5	75	300	/712
TBD	Р	-150	±2 0	TBD	TBD	75	100	TBD
TBD	Р	-150	±20	TBD _	TBD	75	300	TBD
JANSR2N7546U3	Р	-200	±20	505	8.0	75	100	/712
JANSF2N7546U3	Р	-200	±2 0	505	8.0	75	300	/712
TBD	Р	-250	±2 0	TBD	TBD	75	100	TBD
TBD	Р	-250	±2 0	TBD	TBD	75	300	TBD











Radiation Hardened BiPolar Junction **Transistors**

New JANSR RadHard Slash Sheets TID Characterization **ELDRS Characterization**

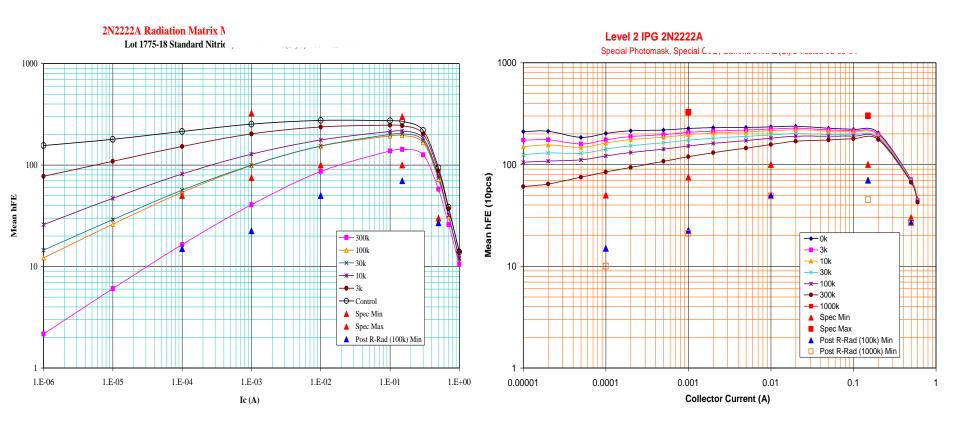




BJT Technology Does Matter

OLD TECHNOLOGY

NEW LEVEL 2 DIE TECHNOLOGY



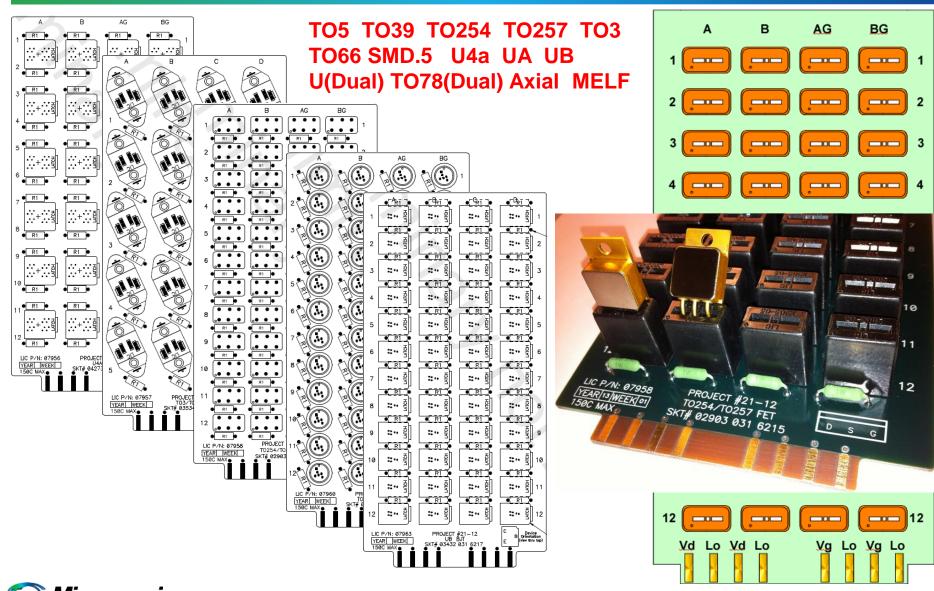


ELDRS Testing on Bipolars

- Dose rate: .01 Rad(s)/ sec. (10 mrads)
- Historical Test facility: Umass- Lowell
 - Co- 60 Source
 - TID, Proton, ELDRS
 - DLA Certified Facility
 - NEW JL SHEPHERD CO-60 irradiator being installed in Lawrence Microsemi HRG facilities
- BiPolar Products tested to date reports available
 - 2N2222A
 - 2N2907A
 - 2N3700
 - 2N2369
- Custom radiation testing



Irradiator Test Boards for Every Occasion:



Microsemi HRG Radiation Testing Roadmap

COMMISSIONING OF FULL IRRADIATION SYSTEM

May 2013

ELDRS 100mRAD/s Data Reporting on JANS Lots

Beginning May 2013 and Thereafter

TID VERSUS ELDRS 100mRAD/s LOT CERTIFICATION

September 2013

ELDRS 100mRAD/s VERSUS 10mRAD/s CERTIFICATION

April 2014

ELDRS 100mRAD/s DATA ON EVERY JANS LOT

Standard Operating Procedure







Microsemi Hybrid Facilities

Linear & POL products





Updated Fabrication & Certification

- Microsemi Hybrid Group
 - 30+ Years (TSI/HPG Microsemi)
- DLA MIL-PRF-38534 Facilities
 - Class H & K approved
 - QML End of line process Non TRB
 - RHA plans approved by DLA



- Utilization of Microsemi RH Die wherever possible
- Standard Non-isolated products
- Standard Isolated products in development







MICROSEMI HRG Hybrid Facilities

NEW MIL-PRF-38534 Class K facility to be set- up in Lawrence!

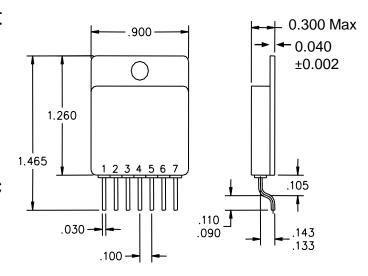
- \$1.5 Million Dollar NEW facility development investment (Class 10K)
- All existing personnel, equipment and processes shall re-locate from current Danvers Massachusetts facility to Microsemi HRG divisional headquarters by June 1, 2013 (17 Mile Move)
- "Rad-Hard Power Hybrid Center of Excellence for Microsemi"
- Additional Cap-ex underway to further enhance operational excellence
- Engineering capacity & personnel have been increased to support growth experienced within our current power hybrid business

Investments are part of Microsemi long term business strategy to support Domestic & International space communities radiation reliability requirements of high level integrated power Hybrid technologies.



ULDO Linear Regulator MHL8701/5

- The MHL 87XX Series are space qualified, ultra low dropout linear regulators designed for military and space flight applications. Assembled in a hermetic package, this series provides an ultra low drop out voltage of 400mV @ 2A. They are optimized for operation at +5V input or +3.3V input.
- Enhanced SEE performance, SET < 5% of Vout
- Thermal shutdown @ 150 °C
- Output Voltage: +1.26V to +4.5V
- Post Rad Output Voltage accuracy +-6%
- Rad- Tolerant to 300 Krad HDR TID
- Rad- Tolerant to 100 Krad Eldrs .01 rads(si)/sec
- LET= 85 MeV (Au ions) No Latch-up
- Fixed & Adjustable output voltages
- 7 Pin Power SIP



Some linear regulators on the market for Space applications have inadequate Single- Event performance due to poor filtering on the output of the part. Designers typically need to add additional protection on the output of linears to improve the SEE performance of the system. With the MHL8701/5 the filter is included in the package. This product has an on- board L-C filter to improve the SEE response of the system to 82 MeV.



Point of Load Switchers- MHP-8564

The MHP series are non-isolated Point of Load switching regulators for high reliability Military and Space distributed power applications. Fully integrated, these include a buck controller, inductor, and input / output capacitors combined in a single package.

MHL 8564 operates from an input voltage of +4.5V to +5.5V providing step down power conversion to output voltages as low as 0.5V or lower

- 150 Krad TID, 75K Eldrs 0.1 rad(si)/sec
- Adjustable or Fixed Output Voltage
- External Sync Option 580Khz-1000Khz
- Free Run nominal @ 500Khz
- Soft Start
- Up to 4.5A Output Current
- Remote Sense option
- Output current limit
- Efficiencies up to 87% @ 3.3Vout
- Line regulation +-0.5% Load +- 1.0% @ 1.21 Voutput @ 1-3A
- Compact package: 0.195 cu-in
- Parallel configurations allow higher currents.

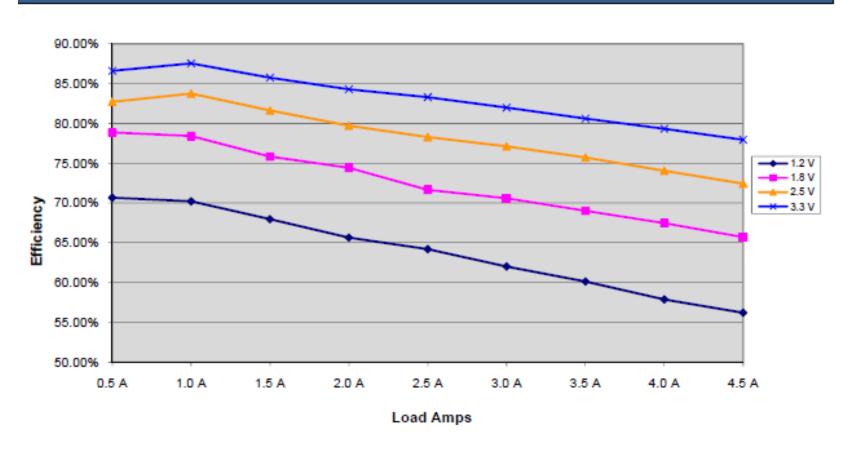
16-PIN Flat pack = L 35.3 X W 36 X H 9.8 mm

This part has more functions vs. the 8565. In addition to the standard shutdown pin, the part has extra connections for managing compensation and frequency synching. It also has the Remote Sense option to provide more accurate output voltages over long runs in the circuit. A most useful option for this part is the ability to parallel outputs with synch circuit



8564 Efficiency Curves





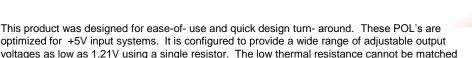


MHP-8565 Point of Load

MHP Point of loads are fully integrated, these include a buck controller, inductor, and input / output capacitors combined in a single package. They operate from an input voltage of +4.5V to +5.5V .providing step down power conversion to output voltages as low as 1.2V @ full current rating or as low as 0.5V (with reduction in current rating).

Operating features include output voltage adjust, output current limit, enable, external synchronization and soft start. Some models can also be setup in a parallel configuration to increase output current capability.

- Rad- Tolerant > 150 Krad HDR TID
- Rad- Tolerant to 75 Krad Eldrs .01 rads(si)/sec



MO-078 = L 27 X W 32 X H 8 mm

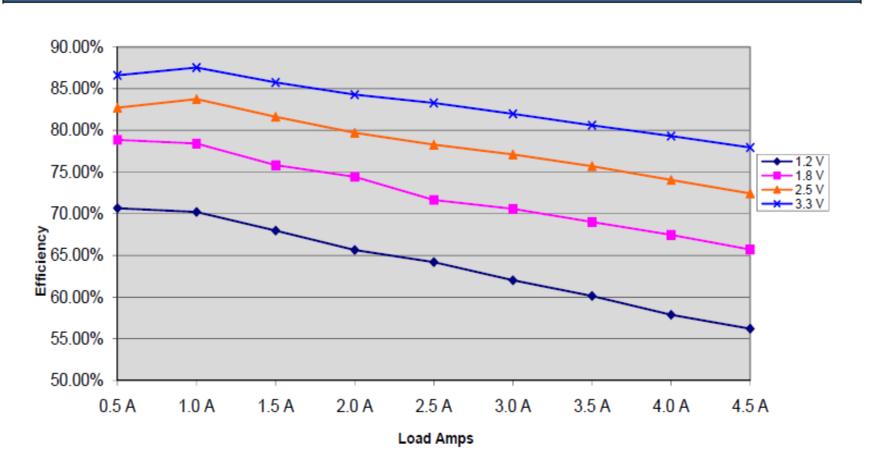
by any competitor of similar class. Better efficiencies and a product that dissipates less power.

- •Up to 3.5A Output Current
- Efficiencies up to 87%
- Low Thermal resistance assembly
 - $R_{\theta j-c} = 2.5$ ° C/W



Typical Efficiency Curves







Product Heritage



Classified programs

CHIRP



117 Multiple programs

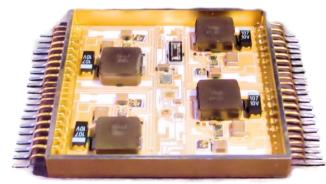


8565A **CHIRP** Multiple



CHIRP

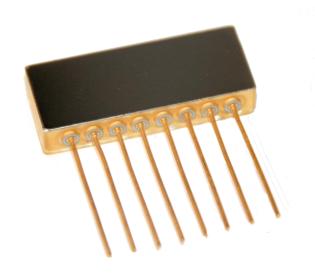
8564S



8566

Flying on ISS





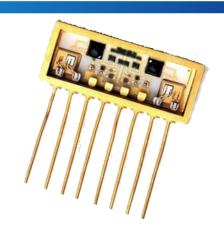
Electromechanical and Solid-State Relays

Rad- Hard, 60V to 200V 5/10/20A



Solid-State Relay Roadmap

- MIL-PRF- 38534
- 5A & 10A Max Current
- Class H & K Screening levels
- Surface Mount & Thru- Hole packages
- Normally open or Normally closed operation



Part #	Description	Rated Switch Voltage	Package / Config.
MHS1005	Dual, 5A Relay	100V	8- Pin SIP/ SMT & Thru- Hole
MHS2005	Dual, 5A Relay	200V	8- Pin SIP/ SMT & Thru- Hole
MHS1010	Dual, 10A	100V	8- Pin SIP/ SMT & Thru- Hole
MHS2010	Dual, 10A	200V	8- Pin SIP/ SMT & Thru- Hole



Solid- State Relays-

- MHS Series are immune to shock and vibration (having no moving parts) and the additional benefit having no contact bounce unlike electromechanical relays
- 100V, 200V Operation
- Accepts Logic Level inputs, (+3.0V- +5.5V)
- 1000V Isolation
- Internal Switch rated at Tj= 150°C
- TID >300Krad; SET = 85 Mev





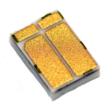
Gallium Nitride Products, MiGaN™

40V to 200V Top Level Introduction – Early Introduction information only



Gallium Nitride (GaN)

- Microsemi GaN products are designed for use in Space and Military applications
 - Therefore, will be considered as 'ITAR' until a 'Commodity Jurisdiction' is determined
- Our GaN products will meet extensive radiation and efficiencies as defined in the market
- The product line is new and under development





GaN vs. RH Si- Part

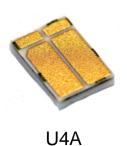
PART NO.	<u>VOLTAGE</u> <u>Vds</u>	CURRENT	<u>PEAK</u>	RDS(ON) (mΩ)	Qg (nC)	FOM = Qg * Rds(on)	DIM <u>(mils)</u>	EST Size
MGN2015	40V	33A	150A	4	11.6	46.4	.162x .065 (4.05 x 1.625)	2
IRHNA57Z60	30V	45	300	4	200	800	.257 sq. (6.4sq)	6
MGN2005	60V	25A	100A	7	10	70	.162x .065 (4.05 x 1.625)	2
IRHNA57064	60V	75	300	6	160	960	.257 sq. (6.4sq)	6
MGN2001	100V	25A	100A	7	10.5	73.5	.162x .065 (4.05 x 1.625)	2
IRHNA67160	100V	56	224	10	170	1700	.257 sq. (6.4sq)	6
MGN2010	200V	12A	40A	25	7.5	187.5	.141 x .065 (3.5 x 1.625)	1.5
IRHNA67260	200V	56	224	29	240	6960	.257 sq. (6.4sq)	6

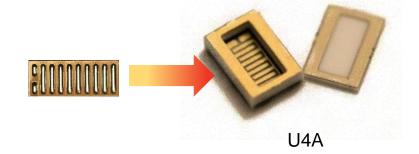
Dramatic improvement in Qg & FOM vs. Vds!



1st Gen GaN product line (preliminary)

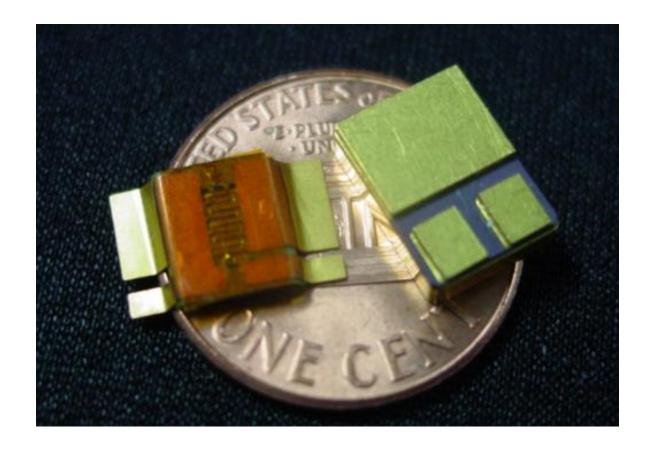
<u>PART NO</u> .	<u>VOLTAGE</u>	<u>CURRENT</u>	<u>PEAK</u>	RDS(ON) (mΩ)	Qg (nC)	FOM- Qg * Rds(on)
MGN2915U4A	40V	33A	150A	4	11.6	46.4
MGN2914U4A	40V	10A	40A	16	3	48
MGN2905U4A	60V	25A	100A	7	10	70
MGN2909U4A	60V	6A	25A	30	2.4	72
MGN2901U4A	100V	25A	100A	7	10.5	73.5
MGN2907U4A	100V	6A	25A	30	2.7	81
MGN2911U4A	150V	12A	40A	25	6.7	167.5
MGN2913U4A	150V	3A	12A	100	1.7	170
MGN2910U4A	200V	12A	40A	25	7.5	187.5
MGN2912U4A	200V	3A	12A	100	1.9	190





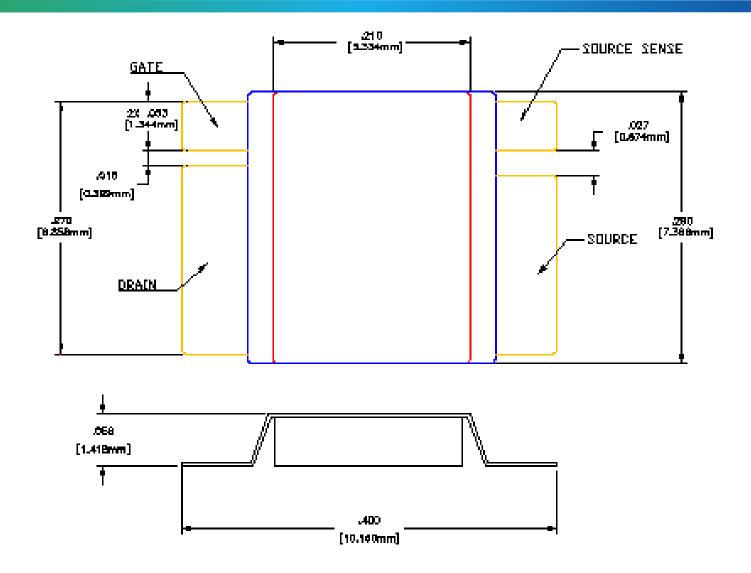


GaN Flex





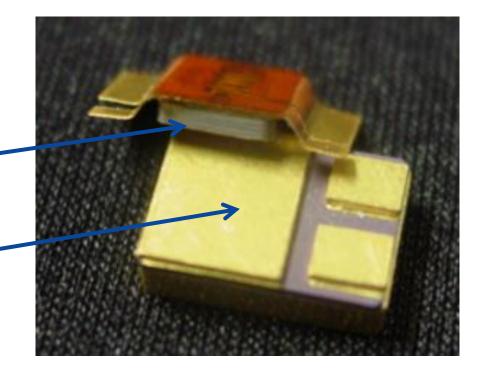
GaN Flex Dimensions





Advantages

- No wirebonds
- Low inductance
- Low thermal resistance
 - Heat transfer through the backside of die
- Low package electrical resistance
 - Less than 0.5 mΩ

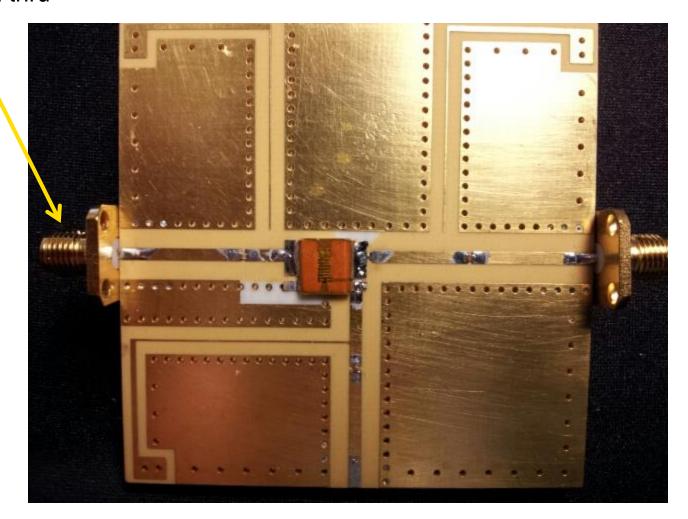


Thermal path

SMD 0.5

GaN Flex RF Testing Set-up

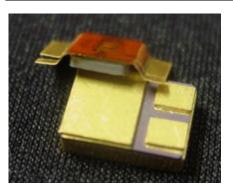
$50 \text{ m}\Omega$ feed thru





1st Gen GaN Flex Product line (preliminary)

<u>PART NO</u> .	<u>VOLTAGE</u>	<u>CURRENT</u>	<u>PEAK</u>	RDS(ON) (mΩ)	Expected Sample Date
MGN2915FLX	40V	33A	150A	4	Sept'13
MGN2914FLX	40V	10A	40A	16	TBD
MGN2905FLX	60V	25A	100A	7	TBD
MGN2909FLX	60V	6A	25A	30	TBD
MGN2901FLX	100V	25A	100A	7	Sept '13
MGN2907FLX	100V	6A	25A	30	Sept '13
MGN2911FLX	150V	12A	40A	25	TBD
MGN2913FLX	150V	3A	12A	100	TBD
MGN2910FLX	200V	12A	40A	25	TBD
MGN2912FLX	200V	3A	12A	100	TBD



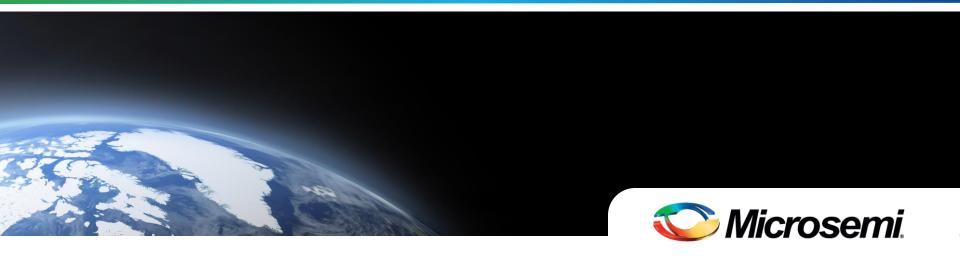
Preliminary Information



Features/ Properties Summary

- Normalized Rds(on) is lower than Si: 1.47 vs. 1.7
- Natural Logic- Level drive
 - +5V gate drive- fully enhanced at +4.5V to +5V
 - Vgsmax= 6.0V!!!
- Small die size will result in much smaller packages
 - High frequency operation increase power density
- Radiation resistant HiRel products in Development
 - Heavy Ion testing showing very good performance
 - TID, ELDRS characterization
- Extremely low parasitic capacitance U4A package
 - Cuts switching losses significantly
 - Extremely low gate charge
 Microsemi
 © 2013 Mic

Power Matters



Thank You